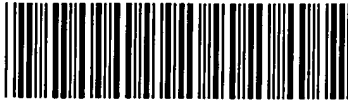


Search Notes

Application/Control No.

09/683,536

Examiner

Ren L. Yan

Applicant(s)/Patent under
Reexamination

HSIEH ET AL.

Art Unit

2854

SEARCHED

Class	Subclass	Date	Examiner
updated search		10/5/05	R. Yan

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR